Application/Control No. Applicant(s)/Patent Under Reexamination 10/743,392 NAIK ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 Juvena W. Loo 2609 **U.S. PATENT DOCUMENTS** Document Number Date Classification Name Country Code-Number-Kind Code MM-YYYY Α US-6,137,807 10-2000 Rusu et al. 370/429 US-В C US-D US-US-Ε US-F US-G US-Н US-Ί US-J US-Κ US-US-М **FOREIGN PATENT DOCUMENTS Document Number** Date Country Name Classification Country Code-Number-Kind Code MM-YYYY Ν 0 Р Q R s T

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